

Product Change Notification - KSRA-28ILGA883

Date: 16 Oct 2017
Product Category: Microprocessors
Notification subject: CCB 3118 Initial Notice: Qualification of MTAI as a final test site for selected AT91SAM9 Atmel device family available in 217L LFBGA package using D2X_TH test platform.
Notification text: **PCN Status:**
 Initial notification.

Microchip Parts Affected:

Please open the attachments found in the attachments field below labeled as PCN_#_Affected_CPN.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of MTAI as a new final test site for selected AT91SAM9XX Atmel device family available in 217L LFBGA package using D2X_TH test platform.

Pre Change:

Tested at ASE9 final test site in singulated units using D10 test platform

Post Change:

Tested at MTAI final test site in strip form using D2X_TH test platform

Pre and Post Change Summary:

	Pre Change	Post Change
Final Test Site	ASE Test (ASE9) final test site	Microchip Technology Thailand (MTAI) final test site
Test Platform	D10 Test Platform	D2X_TH Test Platform
Test Method	Singulated Units	Strip Form

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve manufacturability by qualifying MTAI final test site using D2X_TH test platform

Change Implementation Status:

In Progress

Estimated Qualification Completion Date:

December 2017

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

Time Table Summary:

Workweek	October 2017					→	December 2017				
	40	41	42	43	44		48	49	50	51	52
Initial PCN Issue Date			X								
Qual Report Availability										X	
Final PCN Issue Date										X	

Method to Identify Change:
Traceability code

Qualification Plan:
Please open the attachments included with this PCN labeled as PCN_#_Qual Plan.

Revision History:
October 16, 2017: Issued initial notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

- [PCN_KSRA-28ILGA883_Affected CPN.pdf](#)
- [PCN_KSRA-28ILGA883_Qual Plan.pdf](#)
- [PCN_KSRA-28ILGA883_Affected CPN.xlsx](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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Affected Catalog Part Numbers (CPN)

PCN_ KSRA-28ILGA883
CATALOG_PART_NBR
AT91SAM9G15-CU
AT91SAM9G20B-CU
AT91SAM9G20B-CU-101
AT91SAM9G20B-CU-103
AT91SAM9G20B-CU-999
AT91SAM9G25-CU
AT91SAM9G25-CU-999
AT91SAM9G35-CU
AT91SAM9G35-CU-999
AT91SAM9X25-CU
AT91SAM9X25-CU-999
AT91SAM9X35-CU